

**Search Notes**

Application/Control No.

10/721,598

Examiner

Hanh V. Tran

Applicant(s)/Patent under  
Reexamination

SHEN ET AL

Art Unit

3637

**SEARCHED**

Class	Subclass	Date	Examiner
108	56.3 56.1	3/19/2006	HVT
	57.12		
	51.11		
269	20 266		
	296		
	309		
	310		
269	900	3/19/2006	HVT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search using various key words	3/19/2006	HVT